

Méthodes de réduction de variance en homogénéisation aléatoire

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Séminaire du Laboratoire Jacques-Louis Lions

15 mars 2013

Homogenization of **random materials** often leads to **very expensive** computations, and thus many **practical difficulties**.

Simplify the situation from the **theoretical** viewpoint: consider the simple scalar linear PDE

$$-\operatorname{div} \left[A \left(\frac{x}{\varepsilon}, \omega \right) \nabla u^\varepsilon \right] = f \quad \text{in some domain } \mathcal{D}, \quad u^\varepsilon = 0 \text{ on } \partial\mathcal{D}.$$

Thermal diffusion, ...

Outline of the talk

- Some background materials on random homogenization
- Variance reduction by the control variate approach (generalities)
- A weakly stochastic model (**rare defects**) due to A. Anantharaman and C. Le Bris
- Use this model to build a **surrogate** model and design a **control variate approach** to reduce the variance

In a nutshell: use a weakly stochastic model to improve efficiency for fully stochastic cases.

Random homogenization

Homogenization 1.0.1: the periodic setting

$$-\operatorname{div} \left[A_{\text{per}} \left(\frac{x}{\varepsilon} \right) \nabla u^\varepsilon \right] = f \text{ in } \mathcal{D}, \quad u^\varepsilon = 0 \text{ on } \partial\mathcal{D}, \quad A_{\text{per}} \text{ is } \mathbb{Z}^d\text{-periodic.}$$

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When $\varepsilon \rightarrow 0$, u^ε converges to u^* solution to

$$-\operatorname{div} [A^* \nabla u^*] = f \text{ in } \mathcal{D}, \quad u^* = 0 \text{ on } \partial\mathcal{D}.$$

The effective matrix A^* is given by

$$[A^*]_{ij} = \int_Q e_i^T A_{\text{per}}(y) (e_j + \nabla w_{e_j}(y)) dy, \quad Q = \text{unit cube} = (0, 1)^d,$$

where, for any $p \in \mathbb{R}^d$, w_p solves the so-called **corrector** problem:

$$-\operatorname{div} [A_{\text{per}}(y) (p + \nabla w_p)] = 0, \quad w_p \text{ is } \mathbb{Z}^d\text{-periodic.}$$

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$$-\operatorname{div} [A_{\text{per}}(y) (p + \nabla w_p)] = 0, \quad w_p \text{ is } \mathbb{Z}^d\text{-periodic.}$$

→ The corrector problem is set on the **bounded** domain Q : easy!

Stochastic homogenization: setting

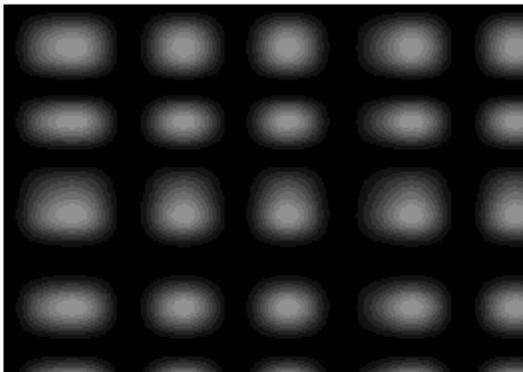
We consider **statistically homogeneous random** materials:

$$-\operatorname{div} \left[A \left(\frac{x}{\varepsilon}, \omega \right) \nabla u^\varepsilon \right] = f \quad \text{in } \mathcal{D}$$

The tensor $A(x, \omega)$ is such that, for any $k \in \mathbb{Z}^d$,

$A(x, \omega)$ and $A(x + k, \omega)$ share the **same** probability distribution.

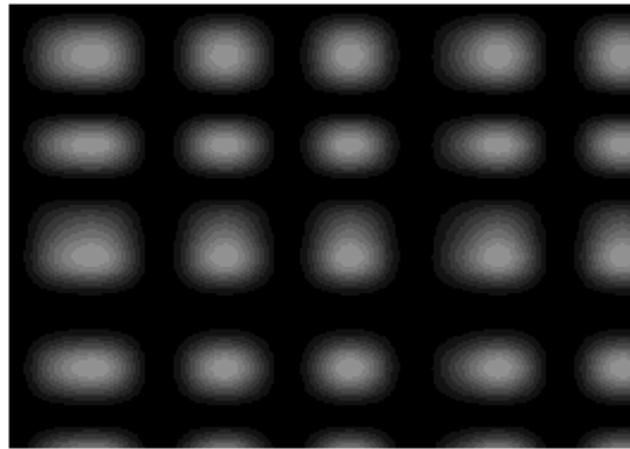
For a given realization of the randomness, properties may be different. But, on average, they are identical: the material is **statistically homogeneous** (and $\mathbb{E} [A(x, \cdot)]$ is \mathbb{Z}^d periodic).



There is some order
in the randomness.

Stochastic homogenization: a typical example

$A(x, \omega)$ and $A(x + k, \omega)$ share the **same** probability distribution.



A typical example of statistically homogeneous function:

$$A(x, \omega) = \sum_{k \in \mathbb{Z}^d} 1_{Q+k}(x) B_{\text{per}}(x) X_k(\omega), \quad Q = (0, 1)^d,$$

where X_k are i.i.d. random variables and B_{per} is \mathbb{Z}^d periodic.

Structure on the probability space $(\Omega, \mathcal{F}, \mathbb{P})$:

- there exists a group action $(\tau_k)_{k \in \mathbb{Z}^d}$ on Ω , that **preserves** the probability measure:

$$\forall k \in \mathbb{Z}^d, \quad \forall B \in \mathcal{F}, \quad \mathbb{P}(\tau_k B) = \mathbb{P}(B).$$

- the action τ is **ergodic**: for any $B \in \mathcal{F}$,

$$\tau_k B = B \text{ for any } k \in \mathbb{Z}^d \quad \implies \quad \mathbb{P}(B) = 0 \text{ or } 1.$$

A function F is **statistically homogeneous (or stationary)** if

$$\forall k \in \mathbb{Z}^d, \quad F(x + k, \omega) = F(x, \tau_k \omega) \quad \text{a.e. and a.s.}$$

If F does not depend on ω , recover the **periodic** case.

- Periodic case: for any $F_{\text{per}} \in L^\infty(\mathbb{R}^d)$ that is \mathbb{Z}^d -periodic,

$$F_{\text{per}}\left(\frac{x}{\varepsilon}\right) \xrightarrow[\varepsilon \rightarrow 0]{*} \int_Q F_{\text{per}}(y) dy \quad \text{in } L^\infty(\mathbb{R}^d), \quad Q = (0, 1)^d.$$

- Stochastic case: for any $F \in L^\infty(\mathbb{R}^d, L^1(\Omega))$ that is statistically homogeneous,

$$F\left(\frac{x}{\varepsilon}, \omega\right) \xrightarrow[\varepsilon \rightarrow 0]{*} \mathbb{E} \left(\int_Q F(y, \cdot) dy \right) \quad \text{in } L^\infty(\mathbb{R}^d), \text{ almost surely.}$$

Stochastic homogenization: result

$$-\operatorname{div} \left[A \left(\frac{x}{\varepsilon}, \omega \right) \nabla u^\varepsilon \right] = f \quad \text{in } \mathcal{D}, \quad u^\varepsilon = 0 \text{ on } \partial\mathcal{D}, \quad A \text{ stat. homog.}$$

$u^\varepsilon(\cdot, \omega)$ converges (a.s.) to u^* solution to

$$-\operatorname{div} [A^* \nabla u^*] = f \quad \text{in } \mathcal{D}, \quad u^* = 0 \text{ on } \partial\mathcal{D},$$

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$$-\operatorname{div} [A^* \nabla u^*] = f \quad \text{in } \mathcal{D}, \quad u^* = 0 \text{ on } \partial\mathcal{D},$$

where the homogenized matrix A^* is given by

$$[A^*]_{ij} = \mathbb{E} \left(\int_Q e_i^T A(y, \cdot) (e_j + \nabla w_{e_j}(y, \cdot)) dy \right),$$

$$\begin{cases} -\operatorname{div} [A(y, \omega) (p + \nabla w_p(y, \omega))] = 0 & \text{in } \mathbb{R}^d, \quad p \in \mathbb{R}^d, \\ \nabla w_p \text{ is stat. homog.}, \quad \mathbb{E} \left(\int_Q \nabla w_p(y, \cdot) dy \right) = 0. \end{cases}$$

In contrast to the periodic case, the corrector problem is set on \mathbb{R}^d .

- Solve the corrector problem on a **truncated domain**:

$$\begin{cases} -\operatorname{div} [A(y, \omega) (p + \nabla w_p^N(y, \omega))] = 0, \\ w_p^N \text{ is } Q_N\text{-periodic, } Q_N = (-N, N)^d. \end{cases}$$

- This yields an approximate (apparent) homogenized matrix

$$[A_N^*]_{ij}(\omega) = \frac{1}{|Q_N|} \int_{Q_N} e_i^T A(y, \omega) \left(e_j + \nabla w_{e_j}^N(y, \omega) \right) dy.$$

Due to numerical truncation, A_N^* is **random**!

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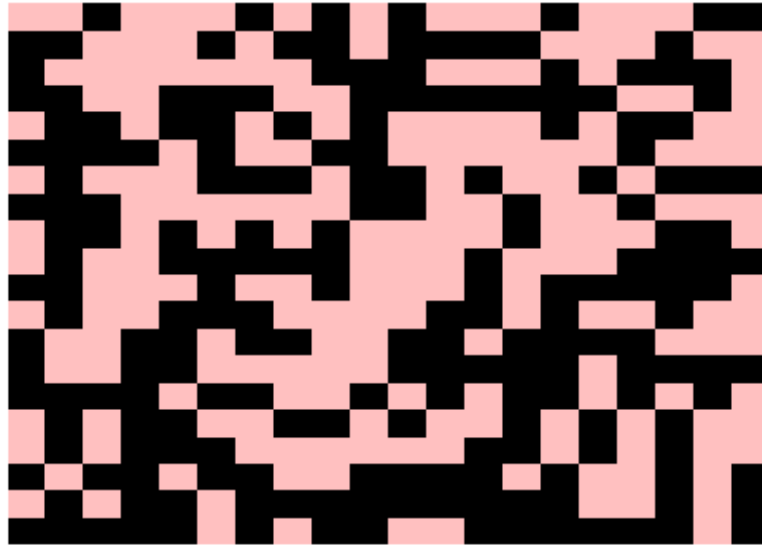
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Due to numerical truncation, A_N^* is **random**!

- We have $\lim_{N \rightarrow \infty} A_N^*(\omega) \rightarrow A^*$ a.s. (Bourgeat/Piatnitski, 2004).
- In practice, N is finite (and possible not large!):

$$A^* - A_N^*(\omega) = \underbrace{A^* - \mathbb{E}[A_N^*]}_{\text{(small) systematic error}} + \underbrace{\mathbb{E}[A_N^*] - A_N^*(\omega)}_{\text{(large) statistical error}}$$

Can we reduce the statistical error? compute more accurately $\mathbb{E}[A_N^*]$?



$$A(x, \omega) = \sum_{k \in \mathbb{Z}^2} 1_{Q+k}(x) a_k(\omega) \text{Id}_2, \quad a_k \text{ independent identically distributed}$$

$a_k = \alpha$ or β with equal probability.

- Consider **M independent realizations** $A^m(y, \omega)$, compute for each
 - the corrector $w_p^{N,m}$ on Q_N :
$$-\operatorname{div} [A^m(y, \omega) (p + \nabla w_p^{N,m}(y, \omega))] = 0, \quad w_p^{N,m} \text{ is } Q_N\text{-periodic,}$$
 - and the approximate homogenized matrix

$$[A_{N,m}^*]_{ij}(\omega) = \frac{1}{|Q_N|} \int_{Q_N} e_i^T A^m(y, \omega) \left(e_j + \nabla w_{e_j}^{N,m}(y, \omega) \right) dy.$$

- Approximate $\mathbb{E}(A_N^*)$ by
$$I_M = \frac{1}{M} \sum_{m=1}^M A_{N,m}^*(\omega).$$

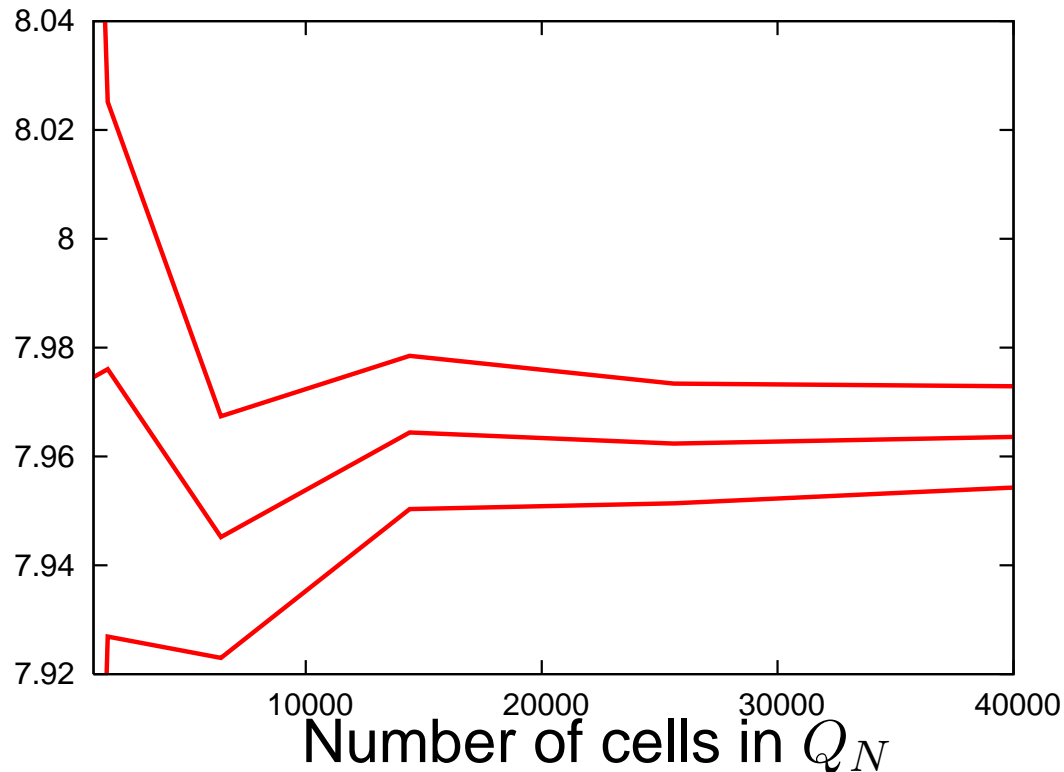
Classical confidence interval: with a probability equal to 95 %,

$$\left| \mathbb{E}([A_N^*]_{ij}) - [I_M]_{ij} \right| \leq 1.96 \frac{\sqrt{\operatorname{Var}([A_N^*]_{ij})}}{\sqrt{M}}$$

The accuracy of I_M is directly linked with the **variance** of A_N^* .

In practice, on a typical example

$I_M \approx \mathbb{E}([A_N^*]_{11})$ (along with confidence intervals) for a given number M of realizations, and several sizes for Q_N .



For moderate N , the statistical error \gg systematic error

Our aim: compute $\mathbb{E}(A_N^*)$ more efficiently, at any given N .

Variance reduction using control variate

Let $X(\omega)$ be a scalar random variable. We want to compute $\mathbb{E}(X)$.

Later, we will take $X(\omega) = [A_N^*(\omega)]_{ij}$.

Estimating $\mathbb{E}(X)$

- standard **Monte Carlo method**: generate M independent realizations of $X(\omega)$, and approximate $\mathbb{E}(X)$ by

$$I_M^{\text{MC}} = \frac{1}{M} \sum_{m=1}^M X(\omega_m) \quad \text{that satisfies} \quad \left| \mathbb{E}(X) - I_M^{\text{MC}} \right| \leq 1.96 \frac{\sqrt{\text{Var}(X)}}{\sqrt{M}}$$

- **control variate method**: consider $X_{\text{app}}(\omega)$ a **random** variable “close” to $X(\omega)$, s.t. $\mathbb{E}[X_{\text{app}}]$ is **analytically** computable, and introduce

$$C(\omega) = X(\omega) - \rho \left(X_{\text{app}}(\omega) - \mathbb{E}[X_{\text{app}}] \right)$$

where ρ is a **deterministic** parameter.

Approximate $\mathbb{E}(X) = \mathbb{E}(C)$ by

$$I_M^{\text{CV}} = \frac{1}{M} \sum_{m=1}^M C(\omega_m) \quad \text{that satisfies} \quad \left| \mathbb{E}(X) - I_M^{\text{CV}} \right| \leq 1.96 \frac{\sqrt{\text{Var}(C)}}{\sqrt{M}}$$

- Accuracy gain iff $\text{Var}(C) < \text{Var}(X)$.

Choice of the control variate $X_{\text{app}}(\omega)$

$$C(\omega) = X(\omega) - \rho \left(X_{\text{app}}(\omega) - \mathbb{E}[X_{\text{app}}] \right), \quad \rho \text{ deterministic parameter}$$

$$I_M^{\text{CV}} = \frac{1}{M} \sum_{m=1}^M C(\omega_m) \quad \text{satisfies} \quad \left| \mathbb{E}(X) - I_M^{\text{CV}} \right| \leq 1.96 \frac{\sqrt{\text{Var}(C)}}{\sqrt{M}}$$

Extreme cases:

- X_{app} is **deterministic**: then $C(\omega) = X(\omega)$ and **no gain!**
- $X_{\text{app}} = X$: for $\rho = 1$, C is deterministic (hence small variance!), but the algorithm requires $\mathbb{E}[X_{\text{app}}] = \mathbb{E}(X)$, which is what we are looking for! **Not practical!**

In general, we need something in-between (problem-dependent).

Choice of the deterministic parameter ρ

$$C(\omega) = X(\omega) - \rho \left(X_{\text{app}}(\omega) - \mathbb{E}[X_{\text{app}}] \right), \quad \rho \text{ deterministic parameter}$$

We wish to minimize the variance of C .

- For any choice of $X_{\text{app}}(\omega)$, there exists an **optimal** ρ that minimizes the variance of C :

$$\rho_{\text{opt}} = \frac{\text{Cov}(X, X_{\text{app}})}{\text{Var}(X_{\text{app}})}$$

Not exactly computable in practice, but can be well enough approximated by an empirical mean.

- For this optimal choice of ρ ,

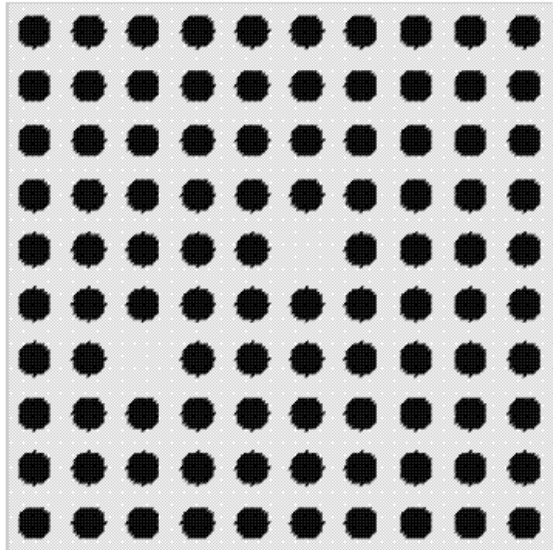
$$\frac{\text{Var}(C)}{\text{Var}(X)} = 1 - \frac{\left(\text{Cov}(X, X_{\text{app}}) \right)^2}{\text{Var}(X) \text{Var}(X_{\text{app}})} < 1$$

The more X and X_{app} are correlated, the better!

A weakly stochastic case: Rare defects in a periodic structure

- A. Anantharaman and C. Le Bris,
- C. R. Acad. Sciences 348 (2010)
 - SIAM MMS 9 (2011)
 - Comm. Comp. Phys. 11 (2012)

Our aim wrt variance reduction: build a surrogate model close to $A_N^*(\omega)$.



A_{per} : fiber

$A_{\text{per}} + C_{\text{per}} = \text{Id}$: no fiber (defect)

$$A(x, \omega) = A_{\text{per}}(x) + b_{\eta}(x, \omega) C_{\text{per}}(x)$$

where A_{per} and C_{per} are both \mathbb{Z}^d -periodic, and

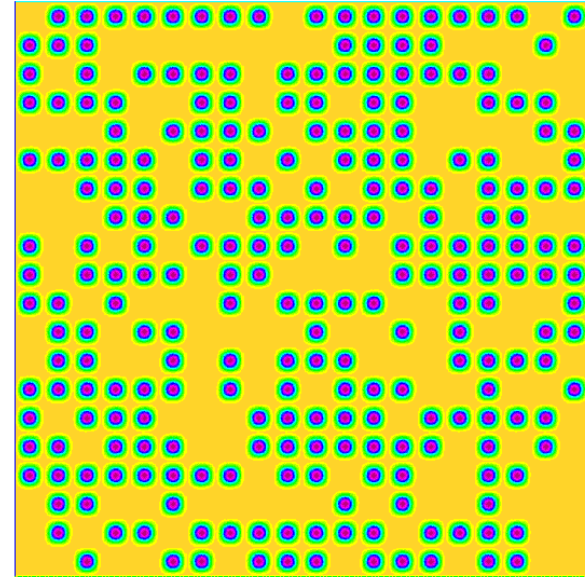
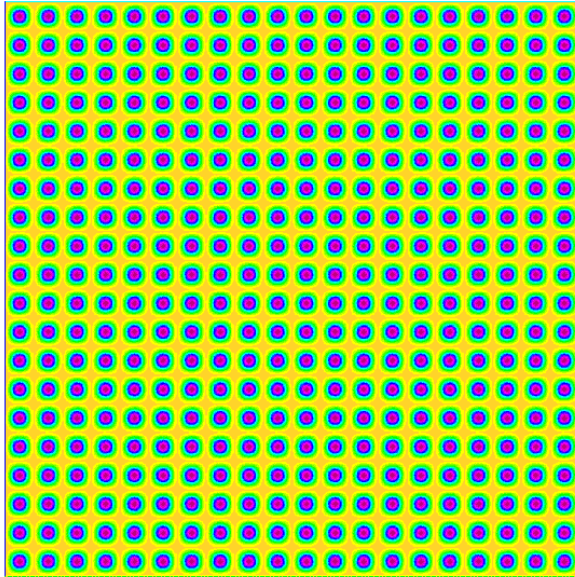
$$b_{\eta}(x, \omega) = \sum_{k \in \mathbb{Z}^d} 1_{Q+k}(x) B_{\eta}^k(\omega), \quad Q = (0, 1)^d,$$

where $\{B_{\eta}^k\}_{k \in \mathbb{Z}^d}$ are i.i.d. random variables:

$$\mathbb{P}(B_{\eta}^k = 1) = \eta, \quad \mathbb{P}(B_{\eta}^k = 0) = 1 - \eta.$$

When η is a small parameter, $A = A_{\text{per}}$ “most of the time”.

Defects may be not so rare!

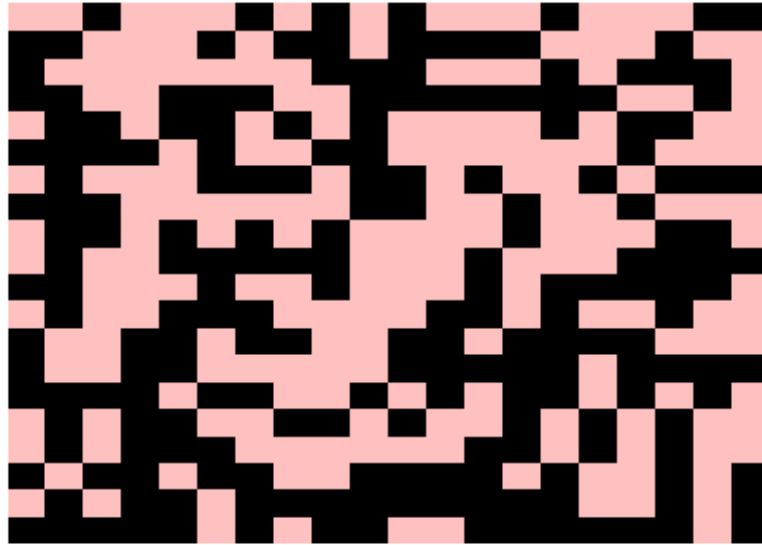


Left: perfect (periodic) material: $\eta = 0$.

Right: a realization of the material with defects of probability $\eta = 0.4$.

When $\eta = 1/2$, defects are as frequent as non-defects!

A realization of the matrix A on Q_N is determined by the collection of the B_k^η (0: fiber; 1: no fiber = defect) in each cell k of Q_N .



$$A(x, \omega) = \sum_{k \in \mathbb{Z}^2} 1_{Q+k}(x) a_k(\omega) \text{Id}_2, \quad \mathbb{P}(a_k = \alpha) = \mathbb{P}(a_k = \beta) = 1/2.$$

$$\text{Then } A(x, \omega) = A_{\text{per}}(x) + b_\eta(x, \omega) C_{\text{per}}(x)$$

with $A_{\text{per}}(x) = \alpha$, $A_{\text{per}}(x) + C_{\text{per}}(x) = \beta$ and $\eta = 1/2$.

- Approximate homogenized matrix:

$$A_N^*(\omega)p = \frac{1}{|Q_N|} \int_{Q_N} A(y, \omega) (\nabla w_p^N(y, \omega) + p) dy$$

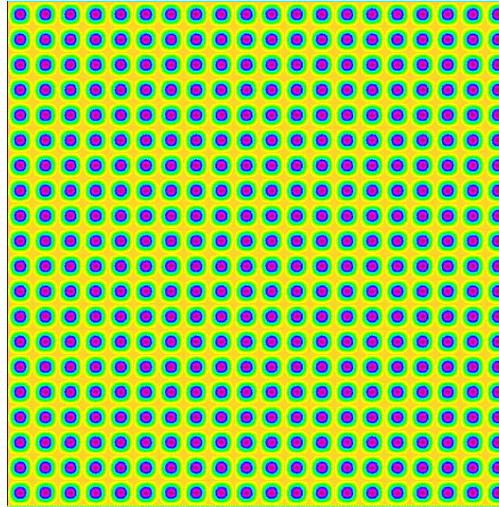
where we solve the corrector problem on $Q_N = (-N, N)^d$:

$$-\operatorname{div} [A(y, \omega) (p + \nabla w_p^N(y, \omega))] = 0, \quad w_p^N \text{ is } Q_N\text{-periodic.}$$

- By enumerating all possible realizations of $A(x, \omega)$ on Q_N , we obtain an expansion of $\mathbb{E}[A_N^*]$ in powers of η :

$$\begin{aligned} \mathbb{E}[A_N^*] &= \sum_{\omega \text{ s.t. } 0 \text{ defect}} A_N^*(\omega) \mathbb{P}(\omega) + \sum_{\omega \text{ s.t. } 1 \text{ defect}} A_N^*(\omega) \mathbb{P}(\omega) + \dots \\ &= (1 - \eta)^{N^d} A_{\text{per}}^* + \sum_{k \in I_N} \eta (1 - \eta)^{N^d - 1} A_N^*(1 \text{ defect in } k) + \dots \\ &= A_{\text{per}}^* + \eta \overline{A}_1^{*,N} + \eta^2 \overline{A}_2^{*,N} + O(\eta^3) \end{aligned}$$

$$\mathbb{E} [A_N^*] = A_{\text{per}}^* + \eta \overline{A_1^{*,N}} + \eta^2 \overline{A_2^{*,N}} + \dots$$



Leading order term given by the periodic (no defect!) situation:

$$-\text{div} [A_{\text{per}} (p + \nabla w_p^0)] = 0, \quad w_p^0 \text{ is } Q\text{-periodic}$$

and

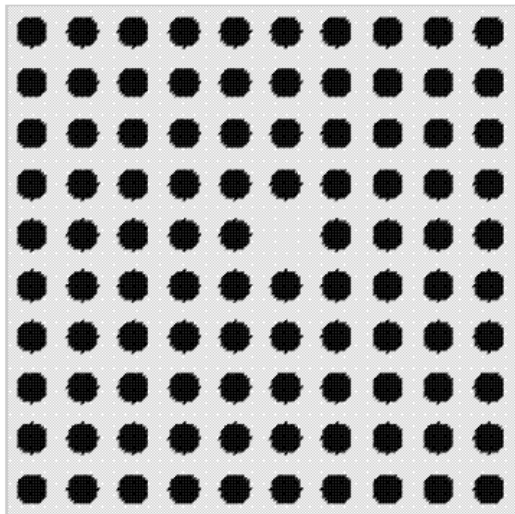
$$A_{\text{per}}^* p = \int_Q A_{\text{per}} (\nabla w_p^0 + p).$$

$$\mathbb{E} [A_N^*] = A_{\text{per}}^* + \eta \overline{A}_1^{*,N} + \eta^2 \overline{A}_2^{*,N} + \dots$$

$$\begin{aligned} \overline{A}_1^{*,N} p &= \frac{1}{|Q_N|} \sum_{k \in I_N} \left[\int_{Q_N} A_1^k (\nabla w_p^{1,k} + p) - \int_{Q_N} A_{\text{per}} (\nabla w_p^0 + p) \right] \\ &= \frac{1}{|Q_N|} \sum_{k \in I_N} \mathcal{A}_k^{1 \text{ def}} p \end{aligned}$$

where w_p^0 is the periodic corrector (no defect) and $w_p^{1,k}$ is the corrector associated to

$$A_1^k = A_{\text{per}} + \mathbf{1}_{Q+k} C_{\text{per}} \quad (\text{material with a single defect in } Q+k)$$



$$-\text{div} \left[A_1^k \left(p + \nabla w_p^{1,k} \right) \right] = 0$$

$w_p^{1,k}$ is Q_N -periodic.

Remark: here, due to periodic BC, $\mathcal{A}_k^{1 \text{ def}}$ independent of k .

$$\mathbb{E} [A_N^*] = A_{\text{per}}^* + \eta \overline{A}_1^{*,N} + \eta^2 \overline{A}_2^{*,N} + \dots$$

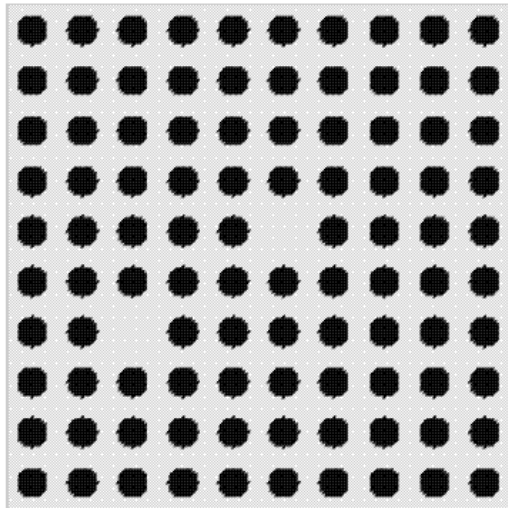
$$\overline{A}_1^{*,N} p = \frac{1}{|Q_N|} \sum_{k \in I_N} \mathcal{A}_k^{1 \text{ def}} p$$

where $\mathcal{A}_k^{1 \text{ def}}$ is the marginal contribution of a single defect in k .

$$\mathbb{E} [A_N^*] = A_{\text{per}}^* + \eta \overline{A}_1^{*,N} + \eta^2 \overline{A}_2^{*,N} + \dots$$

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Similar expression for second order:

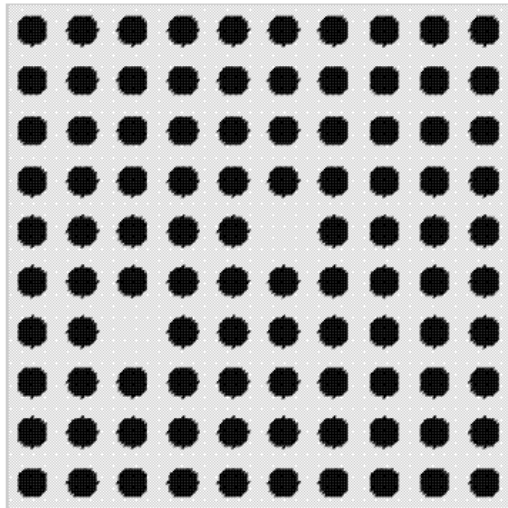
$$\overline{A}_2^{*,N} p = \frac{1}{2|Q_N|} \sum_{k \neq \ell} \mathcal{A}_{k,\ell}^{2 \text{ def}} p$$

Marginal contribution from **pairs of defects**.

$$\mathbb{E} [A_N^*] = A_{\text{per}}^* + \eta \overline{A}_1^{*,N} + \eta^2 \overline{A}_2^{*,N} + \dots$$

$$\overline{A}_1^{*,N} p = \frac{1}{|Q_N|} \sum_{k \in I_N} \mathcal{A}_k^{1 \text{ def}} p$$

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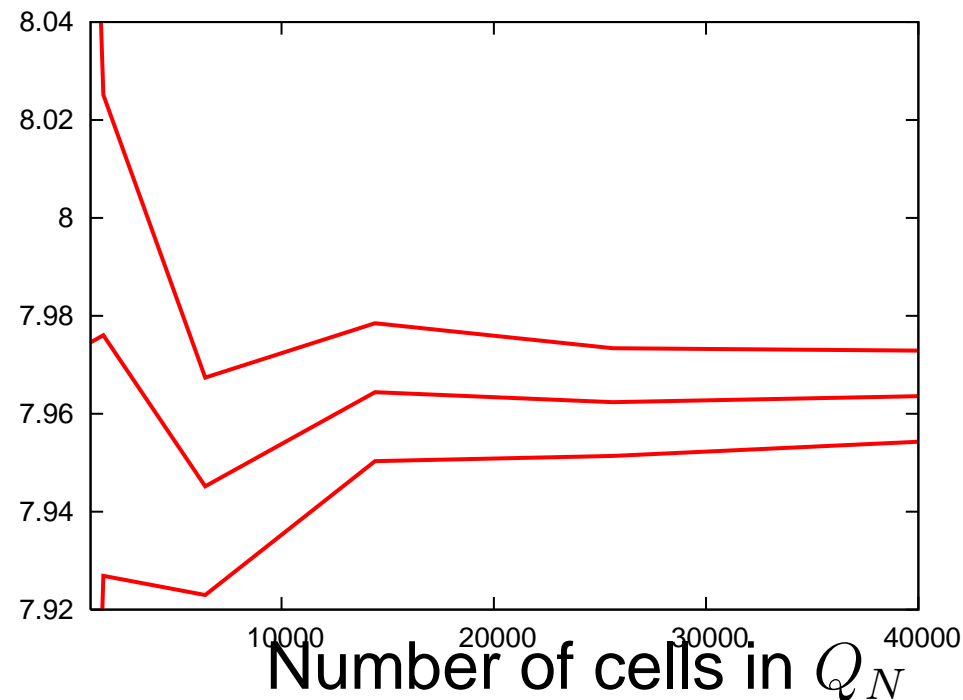
Marginal contribution from **pairs of defects**.

Possible to use a Reduced Basis approach to compute $w_p^{2,k,\ell}$, corrector associated to $A_2^{k,\ell} = A_{\text{per}} + \mathbf{1}_{Q+k} C_{\text{per}} + \mathbf{1}_{Q+\ell} C_{\text{per}}$.

C. Le Bris and F. Thomines, CAM 2012.

A control variate approach

Joint work with W. Minvielle.



Our aim: at any given N , compute $\mathbb{E}(A_N^*)$ more efficiently.

Control variate based on first order approximation - 1

$$\mathbb{E} [A_N^*] = A_{\text{per}}^* + \eta \overline{A}_1^{*,N} + \eta^2 \overline{A}_2^{*,N} + \dots$$

where

$$\eta \overline{A}_1^{*,N} = \frac{\eta}{|Q_N|} \sum_{k \in I_N} \mathcal{A}_k^{1 \text{ def}}$$

is the contribution to the homogenized matrix due to all the **defects** in the system, considered **isolated** one from each other.

We see that

$$\eta \overline{A}_1^{*,N} = \mathbb{E} [A_1^{*,N}]$$

where

$$A_1^{*,N}(\omega) = \frac{1}{|Q_N|} \sum_{k \in I_N} B_{\eta}^k(\omega) \mathcal{A}_k^{1 \text{ def}}$$

where $B_{\eta}^k = 1$ if defect in cell $Q + k$ (which happens with probability η).

Heuristics: $A_{\text{per}}^* + A_1^{*,N}(\omega)$ good approx. of $A_N^*(\omega)$.

Control variate based on first order approximation - 2

$$\mathbb{E} [A_N^*] = A_{\text{per}}^* + \eta \overline{A}_1^{*,N} + \eta^2 \overline{A}_2^{*,N} + \dots$$

We introduce

$$A_{\text{app}}^*(\omega) := A_{\text{per}}^* + A_1^{*,N}(\omega) \quad \text{with} \quad A_1^{*,N}(\omega) := \frac{1}{|Q_N|} \sum_{k \in I_N} B_\eta^k(\omega) \mathcal{A}_k^{1 \text{ def}},$$

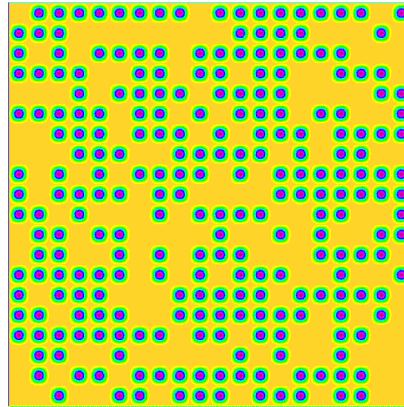
notice that

$$\mathbb{E} [A_N^*] = \mathbb{E} [A_{\text{app}}^*] + \eta^2 \overline{A}_2^{*,N} + \dots$$

and infer that $A_{\text{app}}^*(\omega)$ is a good approximation of $A_N^*(\omega)$.

This is confirmed by the fact that, for any function φ ,

$$\mathbb{E} [\varphi (A_N^*)] = \mathbb{E} [\varphi (A_{\text{app}}^*)] + O(\eta^2).$$



Procedure:

- draw $B_{\eta}^k(\omega)$ in each cell $Q + k$ (defect or not?). This determines the field $A(x, \omega)$ on Q_N .
- compute the associated $A_N^*(\omega)$ (corrector pb on Q_N)
- build the control variate (ρ deterministic parameter)

$$C_N^*(\omega) = A_N^*(\omega) - \rho \left(A_{\text{per}}^* + A_1^{*,N}(\omega) - \mathbb{E} \left[A_{\text{per}}^* + A_1^{*,N}(\omega) \right] \right)$$

$$\text{with } A_1^{*,N}(\omega) = \frac{1}{|Q_N|} \sum_{k \in I_N} B_{\eta}^k(\omega) \mathcal{A}_k^{1 \text{ def}} \quad (\text{expectation analyt. computable}).$$

Control variate based on first order approximation - 4

$$C_N^*(\omega) = A_N^*(\omega) - \rho \left(A_{\text{per}}^* + A_1^{*,N}(\omega) - \mathbb{E} \left[A_{\text{per}}^* + A_1^{*,N}(\omega) \right] \right)$$

- Expect $A_{\text{per}}^* + A_1^{*,N}(\omega)$ to be a good approx. of $A_N^*(\omega)$ (at least for $\eta \ll 1$).
- Observe that $\mathbb{E} [A_N^*(\omega)] = \mathbb{E} [C_N^*(\omega)]$
- IDEA: approximate $\mathbb{E} [A_N^*(\omega)] = \mathbb{E} [C_N^*(\omega)]$ by

$$J_M = \frac{1}{M} \sum_{m=1}^M C_N^*(\omega_m) \quad \left[\text{Confidence interval: } \text{Var } C_N^* \right]$$

Control variate based on first order approximation - 4

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Optimal ρ that minimizes the variance of (an entry of the matrix) C_N^* :

$$\rho_{\text{opt}} = \frac{\text{Cov}(A_N^*, A_1^{*,N})}{\text{Var}(A_1^{*,N})} \quad \text{well approx. by empirical mean, } \rho_{\text{opt}} \xrightarrow{\eta \rightarrow 0} 1$$

Control variate based on second order approximation - 1

$$\mathbb{E} [A_N^*] = A_{\text{per}}^* + \eta \overline{A_1}^{*,N} + \eta^2 \overline{A_2}^{*,N} + \dots$$

where

$$\eta^2 \overline{A_2}^{*,N} = \frac{\eta^2}{2|Q_N|} \sum_{k \neq \ell} \mathcal{A}_{k,\ell}^{2 \text{ def}}$$

is the contribution to the homogenized matrix due to **all pairs of defects** in the system, **located at k and ℓ** . We see that

$$\eta^2 \overline{A_2}^{*,N} = \mathbb{E} \left[A_2^{*,N} \right]$$

where

$$A_2^{*,N}(\omega) = \frac{1}{2|Q_N|} \sum_{k \neq \ell} B_\eta^k(\omega) B_\eta^\ell(\omega) \mathcal{A}_{k,\ell}^{2 \text{ def}}$$

where $B_\eta^k = 1$ if defect in cell $Q + k$ (which happens with probability η).

Control variate based on second order approximation - 2

- Second order control variate approach:

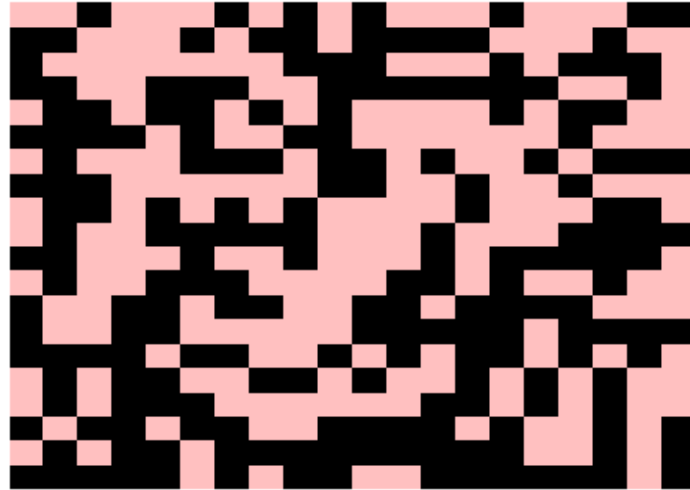
$$C_N^*(\omega) = A_N^*(\omega) - \rho \left(A_{\text{per}}^* + A_1^{*,N}(\omega) - \mathbb{E}[\dots] \right) - \rho_2 \left(A_2^{*,N}(\omega) - \mathbb{E}[\dots] \right)$$

For any entry $1 \leq i, j \leq d$, optimal parameters ρ and ρ_2 by minimizing $\text{Var}([C_N^*]_{ij})$ (inverse a 2×2 matrix).

- Here, we systematically refer to the situation “no defect”, $\eta \ll 1$. It is also possible to refer to the situation “all defects”, $1 - \eta \ll 1$.

The first order correction turns out to be the same, but not the second order correction:

$$C_N^*(\omega) = A_N^*(\omega) - \rho \left(A_{\text{per}}^* + A_1^{*,N}(\omega) \right) - \rho_2 A_{2, \text{wrt } \eta=0}^{*,N}(\omega) - \rho_3 A_{2, \text{wrt } \eta=1}^{*,N}(\omega) - \mathbb{E}[\dots]$$

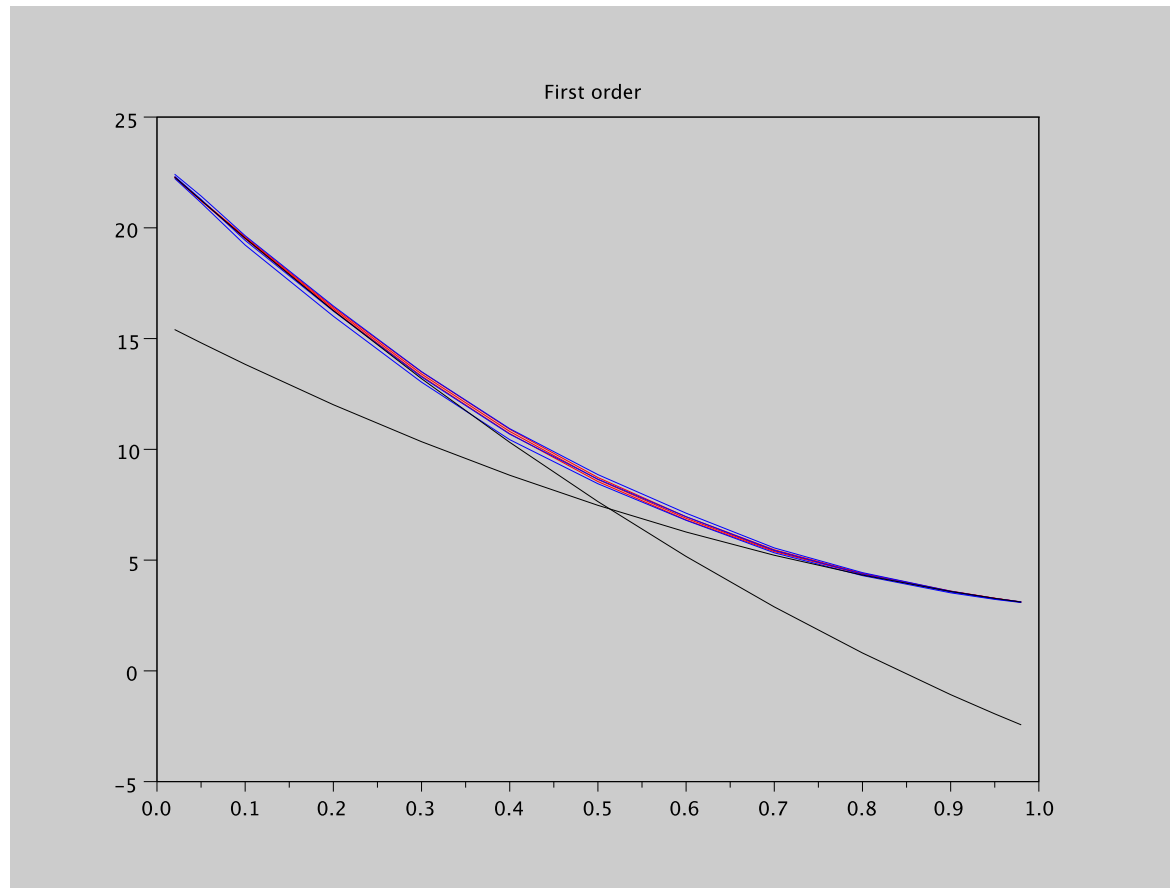


$$A(x, \omega) = \sum_{k \in \mathbb{Z}^2} 1_{Q+k}(x) a_k(\omega) \text{Id}_2, \quad a_k \text{ independent identically distributed}$$

$$\mathbb{P}(a_k = \alpha) = \eta, \quad \mathbb{P}(a_k = \beta) = 1 - \eta.$$

Not always clear to decide who is the defect / background (e.g. when $\eta = 1/2$).

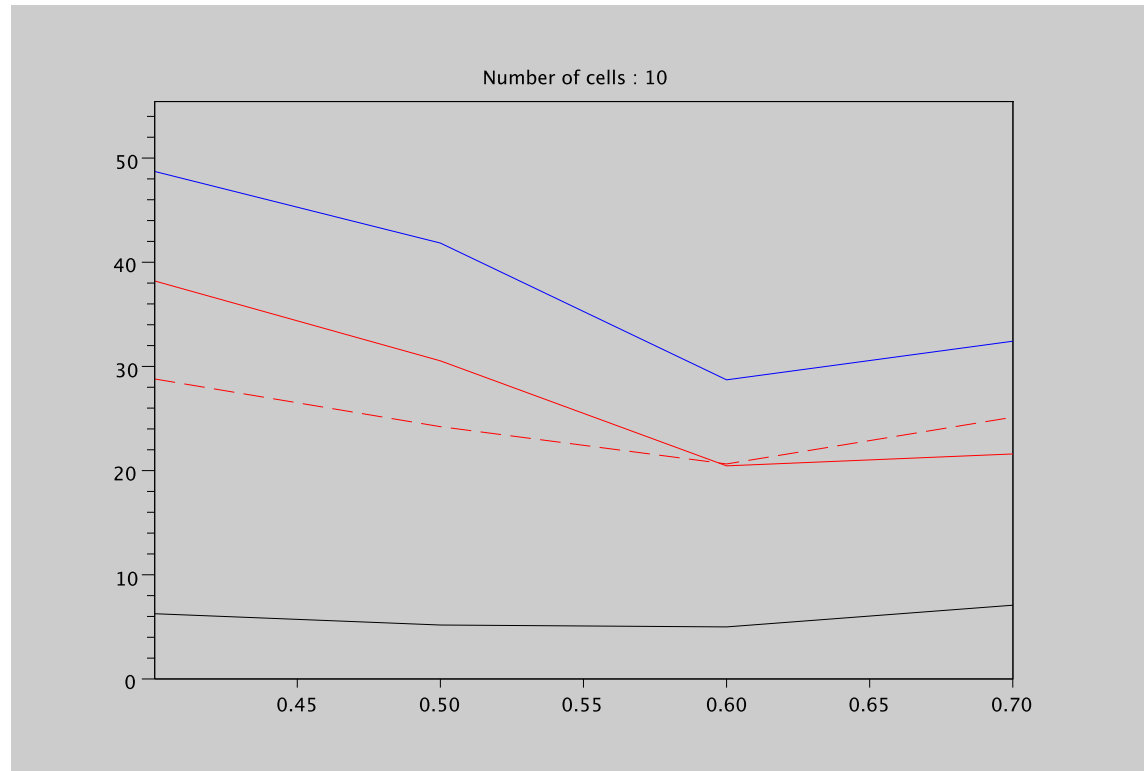
Small contrast test case: $(\alpha, \beta) = (3, 23)$ - Homogenized coefficient



Blue curve: standard Monte Carlo estimator $I_M^{\text{MC}} = M^{-1} \sum_{m=1}^M A_N^*(\omega_m)$

Black curves: weakly stochastic approximation (expansion wrt $\eta = 0$ or $\eta = 1$): inaccurate when $0.4 \leq \eta \leq 0.7$.

Ratios $\text{Var}(A_N^*)/\text{Var}(C_N^*) \equiv \text{CPU time gain}$



Black curves: control variate approach using *first order* approximation.

Red curves: control variate approach using **second order approximation** (wrt $\eta = 0$ OR $\eta = 1$).

Blue curve: control variate approach **simultaneously** using **first and second order approximations at both ends** ($\eta = 0$ AND $\eta = 1$).

Small contrast test case: $(\alpha, \beta) = (3, 23)$ - Efficiency at $\eta = 1/2$

$$C_N^*(\omega) = A_N^*(\omega) - \rho \left(A_{\text{per}}^* + A_1^{*,N}(\omega) - \mathbb{E}[\dots] \right) \\ - \rho_2 \left(A_{2, \text{wrt. } \eta=0}^{*,N}(\omega) - \mathbb{E}[\dots] \right) - \rho_3 \left(A_{2, \text{wrt. } \eta=1}^{*,N}(\omega) - \mathbb{E}[\dots] \right)$$

- Control variate using *first order* approximation ($\rho_2 = \rho_3 = 0$):

- variance ratio = 6
- computing the control variate is inexpensive, hence

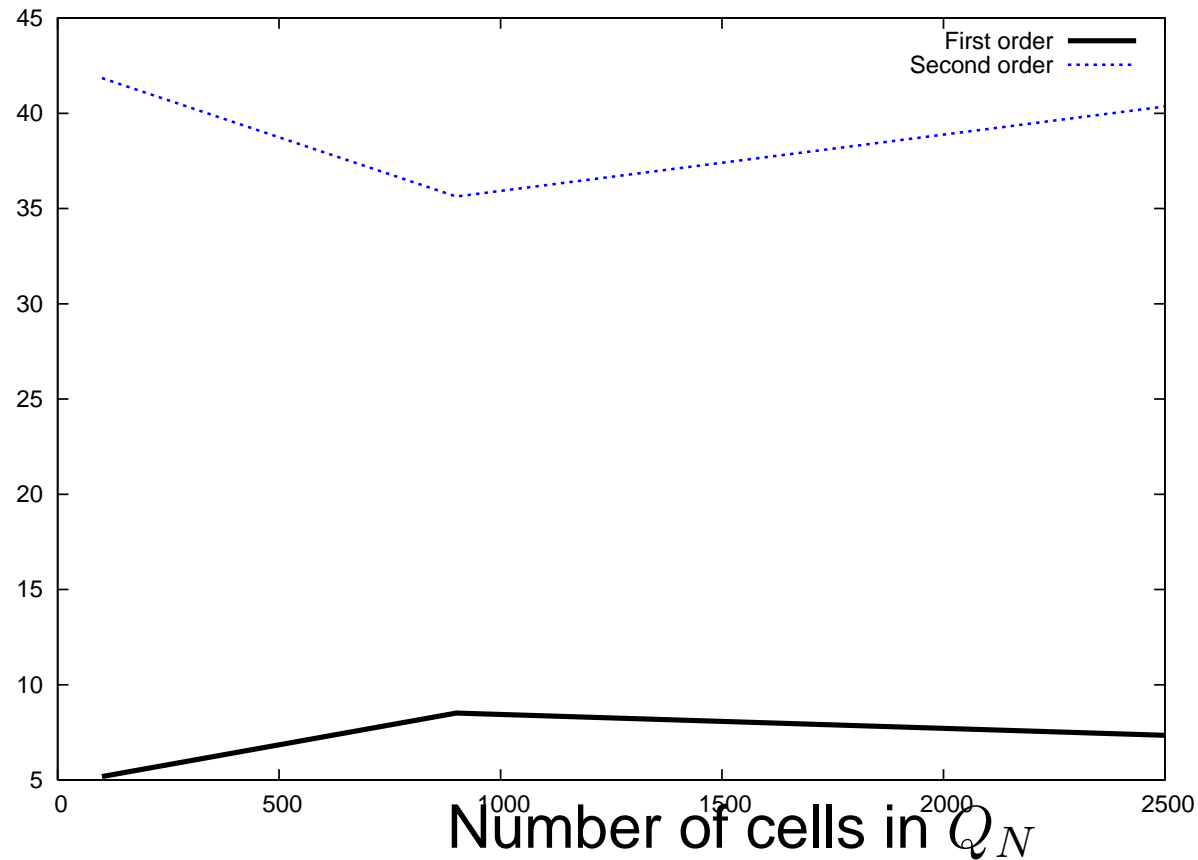
CPU time gain = Variance ratio = 6

- Control variate using **second order** approximation (optimal ρ , ρ_2 and ρ_3):

- variance ratio = 44
- using a RB approach (Le Bris & Thomines, 2012), computing the control variate is inexpensive:

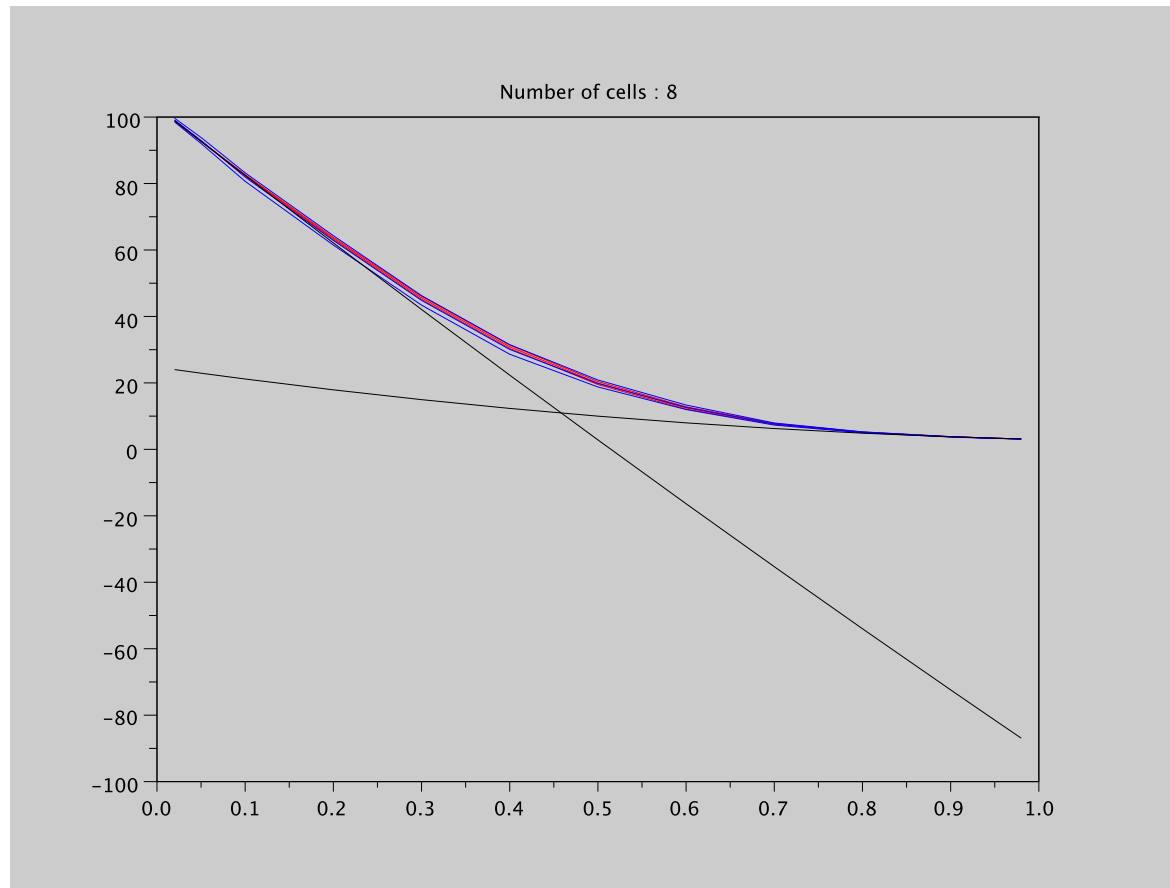
CPU time gain = Variance ratio = 44

Robustness ($\eta = 1/2$) wrt supercell size



Variance reduction ratio (*first order* or **second order** approximation):
insensitive to the supercell size.

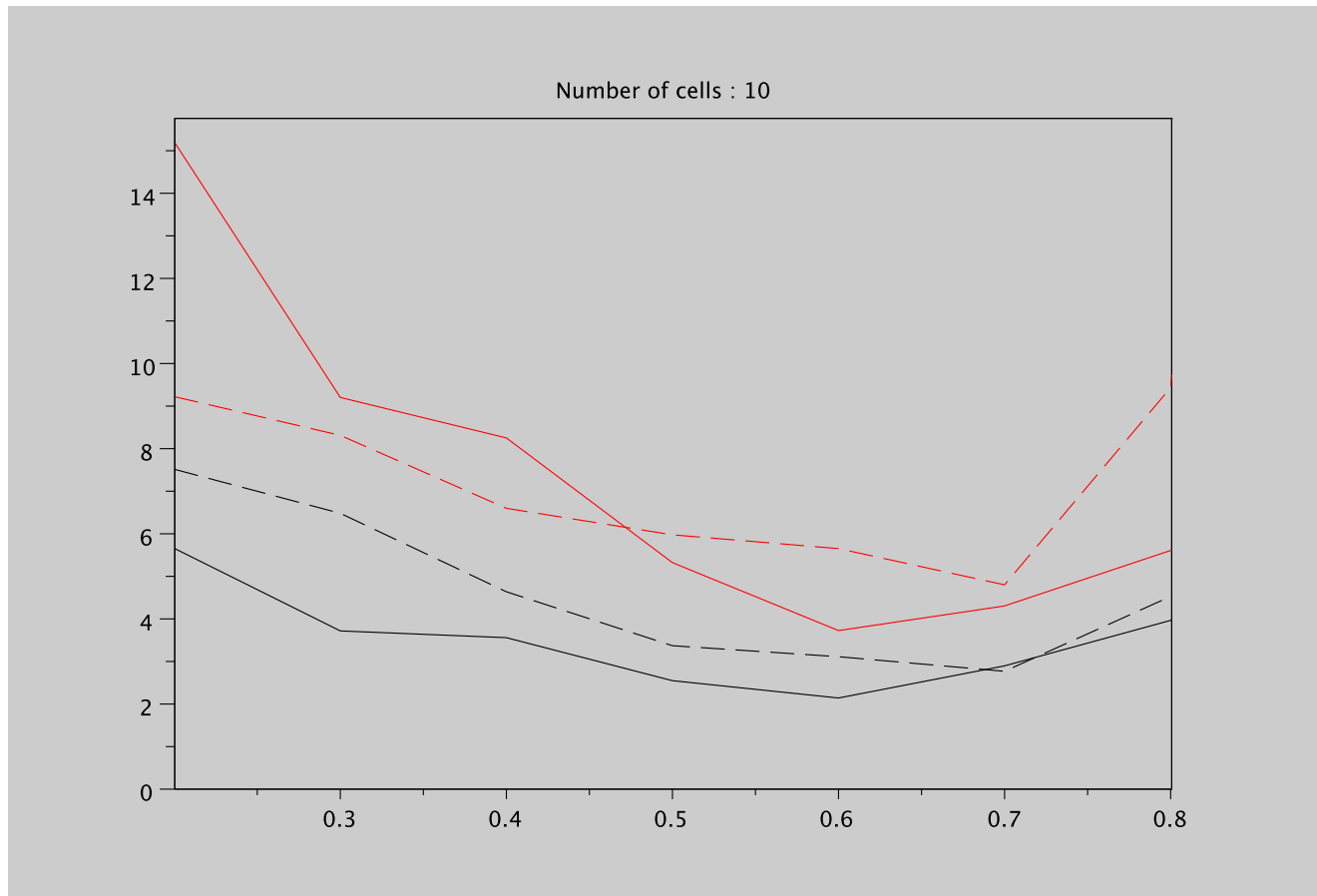
Large contrast test case: $(\alpha, \beta) = (3, 103)$ - Homogenized coefficient



Blue curve: standard Monte Carlo estimator $I_M^{\text{MC}} = M^{-1} \sum_{m=1}^M A_N^*(\omega_m)$

Black curves: weakly stochastic approximation (with α or β as background): inaccurate when $0.3 \leq \eta \leq 0.7$.

Variance ratios (CPU time gain)



Black curves: control variate approach using *first order approximation*

Red curves: control variate approach using **second order approximation**

(wrt $\eta = 0$ OR $\eta = 1$).

Three approaches to compute $\mathbb{E}[A_N^*]$:

- Standard **Monte Carlo** approach with M realizations:

$$\text{error} = \text{statistical error} \propto \sqrt{\text{Var}(A_N^*)/M} \propto \sqrt{\eta/M}$$

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- **Control Variate** approach (first order) with M realizations:

$$\text{error} = \text{statistical error} \propto \sqrt{\text{Var}(C_N^*)/M} \propto \sqrt{\eta^2/M}$$

At equal cost, more accurate than Monte Carlo.

Quantitative estimation of the variance reduction ($\eta \ll 1$)

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- **Control Variate** approach (first order) with M realizations:

$$\text{error} = \text{statistical error} \propto \sqrt{\text{Var}(C_N^*)/M} \propto \sqrt{\eta^2/M}$$

At equal cost, more accurate than Monte Carlo.

- **Expansion** of $\mathbb{E}[A_N^*]$ (Anantharaman / Le Bris) using the same information as the Control Variate approach:

$$\mathbb{E}[A_N^*] = A_{\text{per}}^* + \eta \overline{A_1^{*,N}} + O(\eta^2), \quad \text{error} = \text{systematic error} \propto \eta^2.$$

CV approach needs $M \propto 1/\eta^2 \gg 1$ to reach a similar accuracy.

Regime of interest for our CV approach: η neither close to 0 nor 1.

Conclusions

- We have proposed a **control variate approach** based on a **defect-type** model to better compute $\mathbb{E} [A_N^*]$.
- When none of the phase dominates ($\eta \approx 1/2$), the defect model becomes **inaccurate per se**, but remains **useful as a control variate**.
- For the moment, all computations have been done with the exact $A_2^{*,N}(\omega)$. If we indeed use the RB approach, what impact on the variance reduction?
Up to what can we degrade the surrogate model?
- This approach seems to yield a (~ 10 times) better variance reduction than the antithetic variable approach, which is a generic (and simple) variance reduction approach (less fitted to the homogenization context).

Some references

- Review article:
A. Anantharaman, R. Costaouec, C. Le Bris, F.L., F. Thomines, in Lecture Notes Series, National University of Singapore 2011.
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 - R. Costaouec, C. Le Bris, F.L., Boletin Soc. Esp. Mat. Apl. 2010.
 - X. Blanc, R. Costaouec, C. Le Bris, F.L., Markov Processes and Related Fields 2012 and Lect. Notes Comput. Sci. Eng. 2012.
 - F.L., W. Minvielle, arXiv 1302.0038 (nonlinear case).
- Multi-Level Monte Carlo approach:
Y. Efendiev, C. Kronsbein, F.L., arXiv 1301.2798
- Control variate approach: F.L., W. Minvielle, in preparation.